BFU660F

NPN wideband silicon RF transistor

Rev. 1 — 11 January 2011

Product data sheet

1. Product profile

1.1 General description

NPN silicon microwave transistor for high speed, low noise applications in a plastic, 4-pin dual-emitter SOT343F package.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Observe precautions for handling electrostatic sensitive devices.

Such precautions are described in the *ANSI/ESD S20.20*, *IEC/ST 61340-5*, *JESD625-A* or equivalent standards.

1.2 Features and benefits

- Low noise high linearity RF transistor
- High output third-order intercept point 27 dBm at 1.8 GHz
- 40 GHz f_T silicon technology

1.3 Applications

- Analog/digital cordless applications
- X-band high output buffer amplifier
- ZigBee
- SDARS second stage LNA
- LTE, cellular, UMTS



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1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{CBO}	collector-base voltage	open emitter		-	-	16	V
V_{CEO}	collector-emitter voltage	open base		-	-	5.5	V
V_{EBO}	emitter-base voltage	open collector		-	-	2.5	V
I _C	collector current			-	30	60	mΑ
P _{tot}	total power dissipation	$T_{sp} \le 90 ^{\circ}C$	[1]	-	-	225	mW
h _{FE}	DC current gain	$I_C = 10 \text{ mA}; V_{CE} = 2 \text{ V};$ $T_j = 25 \text{ °C}$		90	135	180	
C _{CBS}	collector-base capacitance	$V_{CB} = 2 \text{ V}; f = 1 \text{ MHz}$		-	138	-	fF
f _T	transition frequency	I_C = 20 mA; V_{CE} = 1 V; f = 2 GHz; T_{amb} = 25 °C		-	21	-	GHz
IP3 _O	output third-order intercept point	I_C = 40 mA; V_{CE} = 4 V; f = 5.8 GHz; T_{amb} = 25 °C		-	28	-	dBm
G _{p(max)}	maximum power gain	$I_C = 30 \text{ mA}; V_{CE} = 1 \text{ V};$ f = 1.8 GHz; $T_{amb} = 25 \text{ °C}$	[2]	-	24	-	dB
NF	noise figure	I_C = 6 mA; V_{CE} = 2 V; f = 1.8 GHz; Γ_S = Γ_{opt} ; Γ_{amb} = 25 °C		-	0.65	-	dB
P _{L(1dB)}	output power at 1 dB gain compression	$\begin{split} &I_{C}=60 \text{ mA; } V_{CE}=4 \text{ V;} \\ &Z_{S}=Z_{L}=50 \Omega; \\ &f=1.8 \text{ GHz; } T_{amb}=25 ^{\circ}\text{C} \end{split}$		-	17	-	dBm

^[1] T_{sp} is the temperature at the solder point of the emitter lead.

2. Pinning information

Table 2. Discrete pinning

21001010		
Description	Simplified outline	Graphic symbol
emitter		
base	3 4	4
emitter		2
collector		1, 3
	2 1	mbb159
	Description emitter base emitter	Description emitter base emitter collector

3. Ordering information

Table 3. Ordering information

Type number	Package				
	Name	Description	Version		
BFU660F	-	plastic surface-mounted flat pack package; reverse pinning; 4 leads	SOT343F		

BFU660F

^[2] $G_{p(max)}$ is the maximum power gain, if K > 1. If K < 1 then $G_{p(max)} = MSG$.

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4. Marking

Table 4. Marking

Type number	Marking	Description
BFU660F	D3*	* = p : made in Hong Kong
		* = t : made in Malaysia
		* = w : made in China

5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

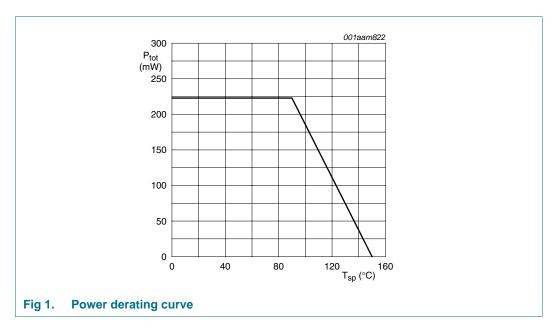
Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	16	V
V_{CEO}	collector-emitter voltage	open base	-	5.5	V
V _{EBO}	emitter-base voltage	open collector	-	2.5	V
I _C	collector current		-	60	mA
P _{tot}	total power dissipation	$T_{sp} \le 90 ^{\circ}C$	<u>[1]</u> -	225	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	junction temperature		-	150	°C

^[1] T_{sp} is the temperature at the solder point of the emitter lead.

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		270	K/W



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7. Characteristics

Table 7. Characteristics

 $T_i = 25$ °C unless otherwise specified

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{(BR)CBO}$	collector-base breakdown voltage	$I_C = 2.5 \mu A; I_E = 0 \text{ mA}$	16	-	-	V
V _{(BR)CEO}	collector-emitter breakdown voltage	$I_C = 1 \text{ mA}$; $I_B = 0 \text{ mA}$	5.5	-	-	V
lc	collector current		-	30	60	mΑ
I _{СВО}	collector-base cut-off current	$I_E = 0 \text{ mA}; V_{CB} = 8 \text{ V}$	-	-	100	nΑ
h _{FE}	DC current gain	$I_C = 10 \text{ mA}; V_{CE} = 2 \text{ V}$	90	135	180	
C _{CES}	collector-emitter capacitance	V _{CB} = 2 V; f = 1 MHz	-	297	-	fF
C _{EBS}	emitter-base capacitance	$V_{EB} = 0.5 \text{ V}; f = 1 \text{ MHz}$	-	664	-	fF
C _{CBS}	collector-base capacitance	V _{CB} = 2 V; f = 1 MHz	-	138	-	fF
f _T	transition frequency	$I_C = 20 \text{ mA}; V_{CE} = 1 \text{ V}; f = 2 \text{ GHz};$ $T_{amb} = 25 \text{ °C}$	-	21	-	GHz
G _{p(max)}	maximum power gain	I_C = 30 mA; V_{CE} = 1 V; T_{amb} = 25 °C	<u>[1]</u>			
		f = 1.5 GHz	-	25	-	dB
		f = 1.8 GHz	-	24	-	dB
		f = 2.4 GHz	-	22	-	dB
		f = 5.8 GHz	-	12.5	-	dB
$ s_{21} ^2$	insertion power gain	I_C = 30 mA; V_{CE} = 1 V; T_{amb} = 25 °C				
		f = 1.5 GHz	-	20	-	dB
		f = 1.8 GHz	-	18.5	-	dB
		f = 2.4 GHz	-	16	-	dB
		f = 5.8 GHz	-	8.5	-	dB
NF	noise figure	I_C = 6 mA; V_{CE} = 2 V; Γ_S = Γ_{opt} ; Γ_{amb} = 25 °C				
		f = 1.5 GHz	-	0.60	-	dB
		f = 1.8 GHz	-	0.65	-	dB
		f = 2.4 GHz	-	0.70	-	dB
		f = 5.8 GHz	-	1.20	-	dB
G _{ass}	associated gain	I_C = 6 mA; V_{CE} = 2 V; Γ_S = Γ_{opt} ; Γ_{amb} = 25 °C				
		f = 1.5 GHz	-	21	-	dB
		f = 1.8 GHz	-	20	-	dB
		f = 2.4 GHz	-	17.5	-	dB
		f = 5.8 GHz	-	12	-	dB
P _{L(1dB)}	output power at 1 dB gain compression	I_C = 60 mA; V_{CE} = 4 V; Z_S = Z_L = 50 Ω ; T_{amb} = 25 °C				
		f = 1.5 GHz	-	17	-	dBm
		f = 1.8 GHz	-	17	-	dBm
		f = 2.4 GHz	-	16	-	dBm
		f = 5.8 GHz	-	18.5	-	dBm

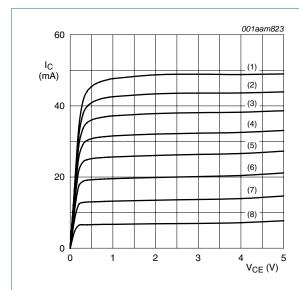
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 Table 7.
 Characteristics ...continued

 $T_i = 25$ °C unless otherwise specified

,	•					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
IP3 _O	output third-order intercept point	I_C = 40 mA; V_{CE} = 4 V; Z_S = Z_L = 50 Ω ; T_{amb} = 25 °C				
		f = 1.5 GHz	-	27	-	dBm
		f = 1.8 GHz	-	27	-	dBm
		f = 2.4 GHz	-	27	-	dBm
		f = 5.8 GHz	-	28	-	dBm

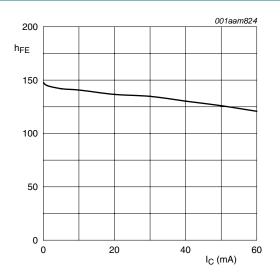
[1] $G_{p(max)}$ is the maximum power gain, if K > 1. If K < 1 then $G_{p(max)} = MSG$.



 $T_{amb} = 25 \, ^{\circ}C.$

- (1) $I_B = 400 \mu A$
- (2) $I_B = 350 \mu A$
- (3) $I_B = 300 \mu A$
- (4) $I_B = 250 \mu A$
- (5) $I_B = 200 \mu A$
- (6) $I_B = 150 \mu A$
- (7) $I_B = 100 \mu A$
- (8) $I_B = 50 \mu A$

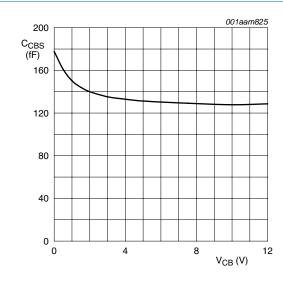
Fig 2. Collector current as a function of collector-emitter voltage; typical values



 $V_{CE} = 2 \text{ V}; T_{amb} = 25 \text{ }^{\circ}\text{C}.$

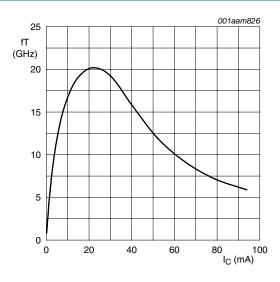
Fig 3. DC current gain as a function of collector current; typical values

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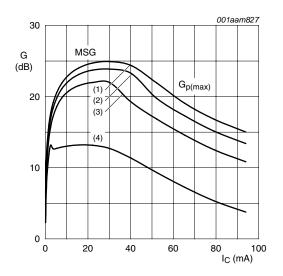
f = 1 MHz, $T_{amb} = 25$ °C.

Fig 4. Collector-base capacitance as a function of collector-base voltage; typical values



 $V_{CE} = 1 \text{ V}$; f = 2 GHz; $T_{amb} = 25 \,^{\circ}\text{C}$.

Fig 5. Transition frequency as a function of collector current; typical values



 $V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ }^{\circ}\text{C}.$

(1) f = 1.5 GHz

(2) f = 1.8 GHz

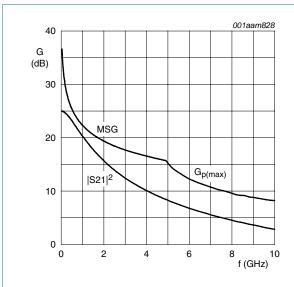
(3) f = 2.4 GHz

(4) f = 5.8 GHz

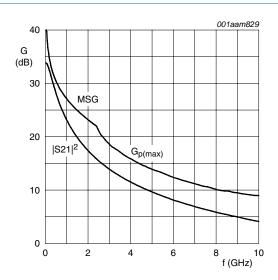
(5) f = 12 GHz

Fig 6. Gain as a function of collector current; typical value

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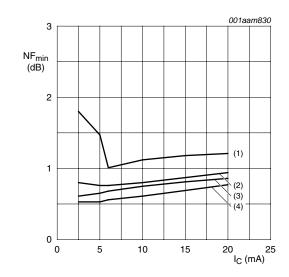
 V_{CE} = 1 V; I_{C} = 5 mA; T_{amb} = 25 °C.



 V_{CE} = 1 V; I_{C} = 30 mA; T_{amb} = 25 °C.

Fig 7. Gain as a function of frequency; typical values

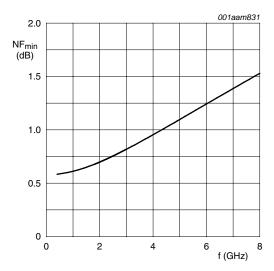




 $V_{CE} = 2 \text{ V}; T_{amb} = 25 \text{ }^{\circ}\text{C}.$

- (1) f = 5.8 GHz
- (2) f = 2.4 GHz
- (3) f = 1.8 GHz
- (4) f = 1.5 GHz

Fig 9. Minimum noise figure as a function of collector current; typical values



 V_{CE} = 2 V; I_{C} = 6 mA; T_{amb} = 25 °C.

Fig 10. Minimum noise figure as a function of frequency; typical values

8. Package outline

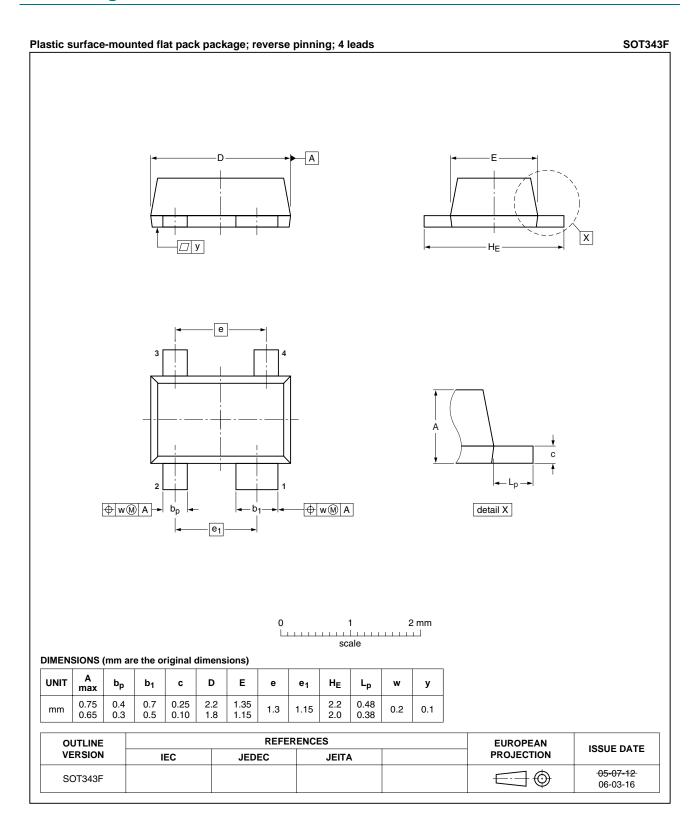


Fig 11. Package outline SOT343F

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9. Abbreviations

Table 8. Abbreviations

Acronym	Description
DC	Direct Current
LNA	Low Noise Amplifier
LTE	Long Term Evolution
NPN	Negative-Positive-Negative
RF	Radio Frequency
SDARS	Satellite Digital Audio Radio Service
UMTS	Universal Mobile Telecommunications System

10. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BFU660F v.1	20110111	Product data sheet	-	-

11. Legal information

11.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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